



HY57V561620C(L)T(P)

4 Banks x 4M x 16Bit Synchronous DRAM

DESCRIPTION

The HY57V561620C(L)T(P) Series is a 268,435,456bit CMOS Synchronous DRAM, ideally suited for the main memory applications which require large memory density and high bandwidth. HY57V561620C(L)T(P) Series is organized as 4banks of 4,194,304x16.

HY57V561620C(L)T(P) Series is offering fully synchronous operation referenced to a positive edge of the clock. All inputs and outputs are synchronized with the rising edge of the clock input. The data paths are internally pipelined to achieve very high bandwidth. All input and output voltage levels are compatible with LVTTTL.

Programmable options include the length of pipeline (Read latency of 2 or 3), the number of consecutive read or write cycles initiated by a single control command (Burst length of 1,2,4,8 or full page), and the burst count sequence(sequential or interleave). A burst of read or write cycles in progress can be terminated by a burst terminate command or can be interrupted and replaced by a new burst read or write command on any cycle. (This pipelined design is not restricted by a '2N' rule.)

FEATURES

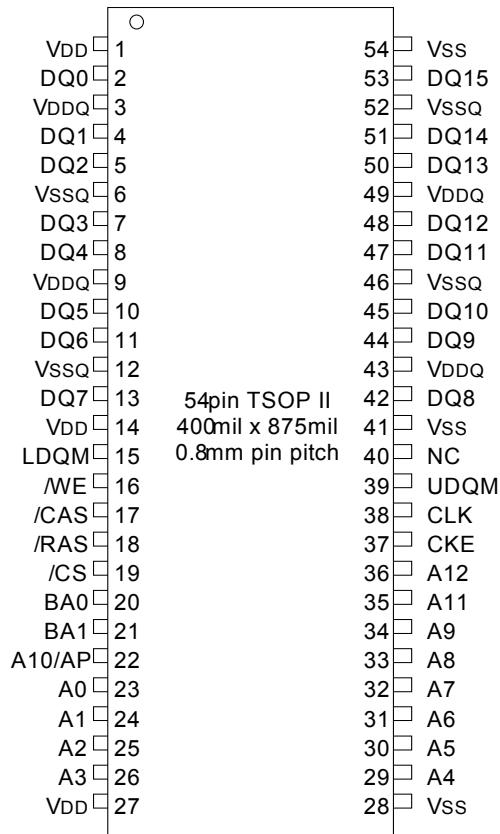
- Single 3.3±0.3V power supply
- All device pins are compatible with LVTTTL interface
- JEDEC standard 400mil 54pin TSOP-II with 0.8mm of pin pitch (Leaded Package or Lead Free Package)
- All inputs and outputs referenced to positive edge of system clock
- Data mask function by UDQM, LDQM
- Internal four banks operation
- Auto refresh and self refresh
- 8192 refresh cycles / 64ms
- Programmable Burst Length and Burst Type
 - 1, 2, 4, 8 or Full page for Sequential Burst
 - 1, 2, 4 or 8 for Interleave Burst
- Programmable $\overline{\text{CAS}}$ Latency ; 2, 3 Clocks

ORDERING INFORMATION

| Part No. | Clock Frequency | Power | Organization | Interface | 400mil 54pin TSOP II |
|-----------------------|-----------------|----------------------------|---------------------|-----------|----------------------------|
| HY57V561620C(L)T(P)-6 | 166MHz | (Normal) / Low Power | 4Banks x 4Mbits x16 | LVTTTL | (Leaded) / Lead Free |
| HY57V561620C(L)T(P)-7 | 143MHz | | | | |
| HY57V561620C(L)T(P)-K | 133MHz | | | | |
| HY57V561620C(L)T(P)-H | 133MHz | | | | |
| HY57V561620C(L)T(P)-8 | 125MHz | | | | |
| HY57V561620C(L)T(P)-P | 100MHz | | | | |
| HY57V561620C(L)T(P)-S | 100MHz | | | | |

Note :

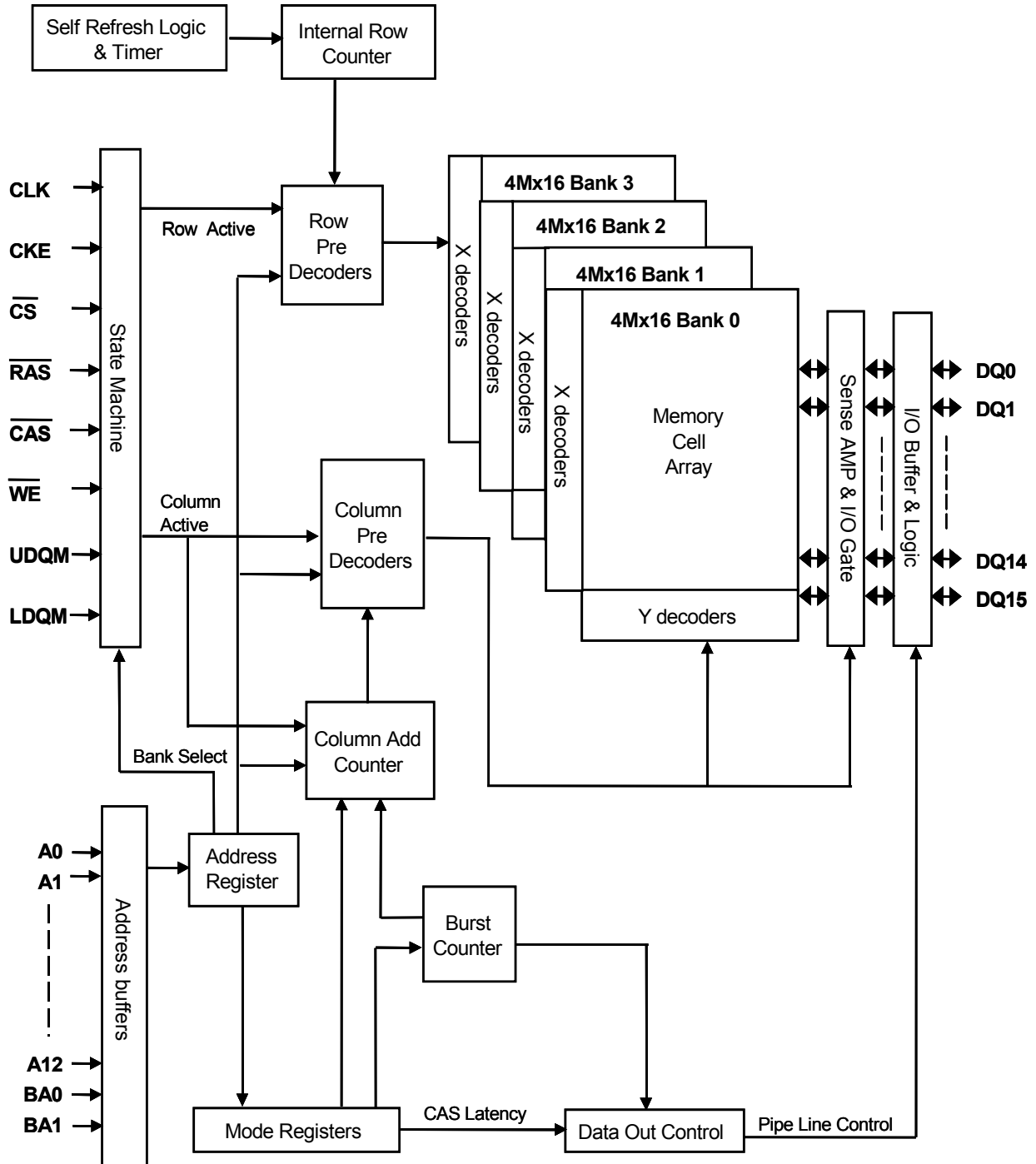
1. HY57V561620CT Series : Nomal power & Leaded 54Pin TSOP II
2. HY57V561620CLT Series : Low power & Leaded 54Pin TSOP II
3. HY57V561620CTP Series : Nomal power & Lead Free 54Pin TSOP II
4. HY57V561620CLTP Series : Low power & Lead Free 54Pin TSOP II

PIN CONFIGURATION

PIN DESCRIPTION

| PIN | PIN NAME | DESCRIPTION |
|---|---|--|
| CLK | Clock | The system clock input. All other inputs are registered to the SDRAM on the rising edge of CLK |
| CKE | Clock Enable | Controls internal clock signal and when deactivated, the SDRAM will be one of the states among power down, suspend or self refresh |
| \overline{CS} | Chip Select | Enables or disables all inputs except CLK, CKE, UDQM and LDQM |
| BA0, BA1 | Bank Address | Selects bank to be activated during \overline{RAS} activity Selects bank to be read/written during \overline{CAS} activity |
| A0 ~ A12 | Address | Row Address : RA0 ~ RA12, Column Address : CA0 ~ CA8 Auto-precharge flag : A10 |
| \overline{RAS} , \overline{CAS} , \overline{WE} | Row Address Strobe, Column Address Strobe, Write Enable | \overline{RAS} , \overline{CAS} and \overline{WE} define the operation Refer function truth table for details |
| UDQM, LDQM | Data Input/Output Mask | Controls output buffers in read mode and masks input data in write mode |
| DQ0 ~ DQ15 | Data Input/Output | Multiplexed data input / output pin |
| VDD/VSS | Power Supply/Ground | Power supply for internal circuits and input buffers |
| VDDQ/VSSQ | Data Output Power/Ground | Power supply for output buffers |
| NC | No Connection | No connection |

FUNCTIONAL BLOCK DIAGRAM

4Mbit x 4banks x 16 I/O Synchronous DRAM



ABSOLUTE MAXIMUM RATINGS

| Parameter | Symbol | Rating | Unit |
|------------------------------------|-----------|------------|----------|
| Ambient Temperature | TA | 0 ~ 70 | °C |
| Storage Temperature | TSTG | -55 ~ 125 | °C |
| Voltage on Any Pin relative to VSS | VIN, VOUT | -1.0 ~ 4.6 | V |
| Voltage on VDD relative to VSS | VDD, VDDQ | -1.0 ~ 4.6 | V |
| Short Circuit Output Current | IOS | 50 | mA |
| Power Dissipation | PD | 1 | W |
| Soldering Temperature · Time | TSOLDER | 260 · 10 | °C · Sec |

Note : Operation at above absolute maximum rating can adversely affect device reliability

DC OPERATING CONDITION (TA=0 to 70°C)

| Parameter | Symbol | Min | Typ. | Max | Unit | Note |
|----------------------|-----------|-------|------|------------|------|------|
| Power Supply Voltage | VDD, VDDQ | 3.0 | 3.3 | 3.6 | V | 1 |
| Input High Voltage | VIH | 2.0 | 3.0 | VDDQ + 0.3 | V | 1,2 |
| Input Low Voltage | VIL | - 0.3 | 0 | 0.8 | V | 1,3 |

Note :

- 1.All voltages are referenced to VSS = 0V
- 2.VIH (max) is acceptable 5.6V AC pulse width with ≤3ns of duration
- 3.VIL (min) is acceptable -2.0V AC pulse width with ≤3ns of duration

AC OPERATING CONDITION (TA=0 to 70°C, VDD=3.3 ± 0.3V, VSS=0V)

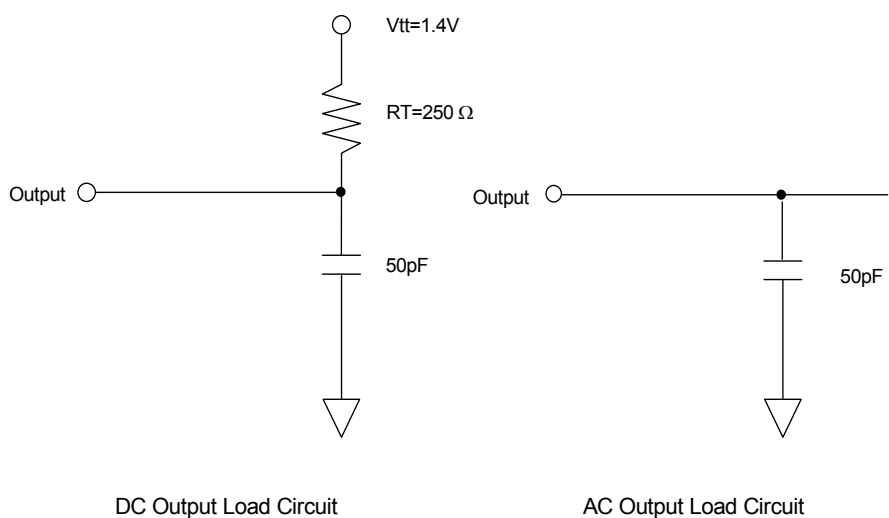
| Parameter | Symbol | Value | Unit | Note |
|---|-----------|---------|------|------|
| AC Input High / Low Level Voltage | VIH / VIL | 2.4/0.4 | V | |
| Input Timing Measurement Reference Level Voltage | Vtrip | 1.4 | V | |
| Input Rise / Fall Time | tR / tF | 1 | ns | |
| Output Timing Measurement Reference Level | Voutref | 1.4 | V | |
| Output Load Capacitance for Access Time Measurement | CL | 50 | pF | 1 |

Note :

1. Output load to measure access time is equivalent to two TTL gates and one capacitor (50pF)
For details, refer to AC/DC output circuit

CAPACITANCE (TA=25°C, f=1MHz)

| Parameter | Pin | Symbol | -6/7/K/H | | -8/P/S | | Unit |
|---------------------------------|---|--------|----------|-----|--------|-----|------|
| | | | Min | Max | Min | Max | |
| Input capacitance | CLK | Cl1 | 2.5 | 3.5 | 2.5 | 4.0 | pF |
| | A0 ~ A12, BA0, BA1, CKE, CS, RAS, CAS, WE, UDQM, LDQM | Cl2 | 2.5 | 3.8 | 2.5 | 5.0 | pF |
| Data input / output capacitance | DQ0 ~ DQ15 | Cl/O | 4.0 | 6.5 | 4.0 | 6.5 | pF |

OUTPUT LOAD CIRCUIT

DC CHARACTERISTICS I (TA=0 to 70°C, VDD=3.3±0.3V)

| Parameter | Symbol | Min. | Max | Unit | Note |
|------------------------|--------|------|-----|------|------------|
| Input Leakage Current | ILI | -1 | 1 | uA | 1 |
| Output Leakage Current | ILO | -1 | 1 | uA | 2 |
| Output High Voltage | VOH | 2.4 | - | V | IOH = -4mA |
| Output Low Voltage | VOL | - | 0.4 | V | IOL = +4mA |

Note :

1. VIN = 0 to 3.6V, All other pins are not tested under VIN =0V
2. DOUT is disabled, VOUT=0 to 3.6V

DC CHARACTERISTICS II (TA=0 to 70°C, VDD=3.3±0.3V, VSS=0V)

| Parameter | Symbol | Test Condition | Speed | | | | | | | Unit | Note |
|---|--------|--|-------|-----|-----|-----|-----|-----|-----|------|------|
| | | | -6 | -7 | -K | -H | -8 | -P | -S | | |
| Operating Current | IDD1 | Burst length=1, One bank active tRC ≥ tRC(min), IOL=0mA | 130 | 110 | 110 | 110 | 100 | 100 | 100 | mA | 1 |
| Precharge Standby Current in Power Down Mode | IDD2P | CKE ≤ VIL(max), tCK = 15ns | 2 | | | | | | | mA | |
| | IDD2PS | CKE ≤ VIL(max), tCK = ∞ | 1 | | | | | | | | |
| Precharge Standby Current in Non Power Down Mode | IDD2N | CKE ≥ VIH(min), \overline{CS} ≥ VIH(min), tCK = 15ns Input signals are changed one time during 30ns. All other pins ≥ VDD-0.2V or ≤ 0.2V | 20 | | | | | | | mA | |
| | IDD2NS | CKE ≥ VIH(min), tCK = ∞ Input signals are stable. | 10 | | | | | | | | |
| Active Standby Current in Power Down Mode | IDD3P | CKE ≤ VIL(max), tCK = 15ns | 3 | | | | | | | mA | |
| | IDD3PS | CKE ≤ VIL(max), tCK = ∞ | 3 | | | | | | | | |
| Active Standby Current in Non Power Down Mode | IDD3N | CKE ≥ VIH(min), \overline{CS} ≥ VIH(min), tCK = 15ns Input signals are changed one time during 30ns. All other pins ≥ VDD-0.2V or ≤ 0.2V | 30 | | | | | | | mA | |
| | IDD3NS | CKE ≥ VIH(min), tCK = ∞ Input signals are stable. | 25 | | | | | | | | |
| Burst Mode Operating Current | IDD4 | tCK ≥ tCK(min), IOL=0mA All banks active | 150 | 130 | 130 | 130 | 130 | 110 | 110 | mA | 1 |
| Auto Refresh Current | IDD5 | tRRC ≥ tRRC(min), All banks active | 220 | 220 | 220 | 220 | 200 | 200 | 200 | mA | 2 |
| Self Refresh Current | IDD6 | CKE ≤ 0.2V | 3 | | | | | | | mA | 3 |
| | | | 1.5 | | | | | | | mA | 4 |

Note :

- 1.IDD1 and IDD4 depend on output loading and cycle rates. Specified values are measured with the output open
- 2.Min. of tRRC (Refresh \overline{RAS} cycle time) is shown at AC CHARACTERISTICS II
- 3.HY57V561620CT(P)-6/7/K/H/8/P/S
- 4.HY57V561620CLT(P)-6/7/K/H/8/P/S

AC CHARACTERISTICS I (AC operating conditions unless otherwise noted)

| Parameter | | Symbol | -6 | | -7 | | -K | | -H | | -8 | | -P | | -S | | Unit | Note |
|-----------------------------------|-------------------------------------|--------|-----|------|-----|------|-----|------|-----|------|-----|------|-----|------|-----|------|------|------|
| | | | Min | Max | Min | Max | Min | Max | Min | Max | Min | Max | Min | Max | Min | Max | | |
| System Clock Cycle Time | $\overline{\text{CAS}}$ Latency = 3 | tCK3 | 6 | 1000 | 7 | 1000 | 7.5 | 1000 | 7.5 | 1000 | 8 | 1000 | 10 | 1000 | 10 | 1000 | ns | |
| | $\overline{\text{CAS}}$ Latency = 2 | tCK2 | 7.5 | | 10 | | 7.5 | | 10 | | 10 | | 10 | | 12 | | ns | |
| Clock High Pulse Width | | tCHW | 2.5 | - | 2.5 | - | 2.5 | - | 2.5 | - | 3 | - | 3 | - | 3 | - | ns | 1 |
| Clock Low Pulse Width | | tCLW | 2.5 | - | 2.5 | - | 2.5 | - | 2.5 | - | 3 | - | 3 | - | 3 | - | ns | 1 |
| Access Time From Clock | $\overline{\text{CAS}}$ Latency = 3 | tAC3 | - | 5.4 | - | 5.4 | - | 5.4 | - | 5.4 | - | 6 | - | 6 | - | 6 | ns | 2 |
| | $\overline{\text{CAS}}$ Latency = 2 | tAC2 | - | 6 | - | 6 | - | 5.4 | - | 6 | - | 6 | - | 6 | - | 6 | ns | |
| Data-Out Hold Time | | tOH | 2.7 | - | 2.7 | - | 2.7 | - | 2.7 | - | 3 | - | 3 | - | 3 | - | ns | |
| Data-Input Setup Time | | tDS | 1.5 | - | 1.5 | - | 1.5 | - | 1.5 | - | 2 | - | 2 | - | 2 | - | ns | 1 |
| Data-Input Hold Time | | tDH | 0.8 | - | 0.8 | - | 0.8 | - | 0.8 | - | 1 | - | 1 | - | 1 | - | ns | 1 |
| Address Setup Time | | tAS | 1.5 | - | 1.5 | - | 1.5 | - | 1.5 | - | 2 | - | 2 | - | 2 | - | ns | 1 |
| Address Hold Time | | tAH | 0.8 | - | 0.8 | - | 0.8 | - | 0.8 | - | 1 | - | 1 | - | 1 | - | ns | 1 |
| CKE Setup Time | | tCKS | 1.5 | - | 1.5 | - | 1.5 | - | 1.5 | - | 2 | - | 2 | - | 2 | - | ns | 1 |
| CKE Hold Time | | tCKH | 0.8 | - | 0.8 | - | 0.8 | - | 0.8 | - | 1 | - | 1 | - | 1 | - | ns | 1 |
| Command Setup Time | | tCS | 1.5 | - | 1.5 | - | 1.5 | - | 1.5 | - | 2 | - | 2 | - | 2 | - | ns | 1 |
| Command Hold Time | | tCH | 0.8 | - | 0.8 | - | 0.8 | - | 0.8 | - | 1 | - | 1 | - | 1 | - | ns | 1 |
| CLK to Data Output in Low-Z Time | | tOLZ | 1 | - | 1 | - | 1 | - | 1 | - | 1 | - | 1 | - | 1 | - | ns | |
| CLK to Data Output in High-Z Time | $\overline{\text{CAS}}$ Latency = 3 | tOHZ3 | 2.7 | 5.4 | 2.7 | 5.4 | 2.7 | 5.4 | 2.7 | 5.4 | 3 | 6 | 3 | 6 | 3 | 6 | ns | |
| | $\overline{\text{CAS}}$ Latency = 2 | tOHZ2 | 2.7 | 5.4 | 2.7 | 5.4 | 2.7 | 5.4 | 3 | 6 | 3 | 6 | 3 | 6 | 3 | 6 | ns | |

Note :

1. Assume tR / tF (input rise and fall time) is 1ns
2. Access times to be measured with input signals of 1v/ns edge rate

AC CHARACTERISTICS II

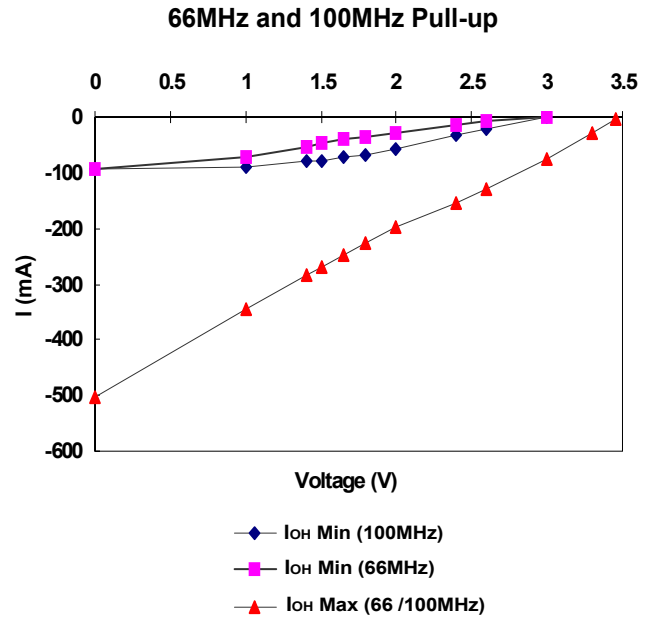
| Parameter | | Symbol | -6 | | -7 | | -K | | -H | | -8 | | -P | | -S | | Unit | Note |
|--------------------------------|-----------------|--------|-----|------|-----|------|-----|------|-----|------|-----|------|-----|------|-----|------|------|------|
| | | | Min | Max | Min | Max | Min | Max | Min | Max | Min | Max | Min | Max | Min | Max | | |
| RAS Cycle Time | Operation | tRC | 60 | - | 60 | - | 60 | - | 65 | - | 68 | - | 70 | - | 70 | - | ns | |
| | Auto Refresh | tRRC | 60 | - | 60 | - | 60 | - | 65 | - | 68 | - | 70 | - | 70 | - | ns | |
| RAS to CAS Delay | | tRCD | 18 | - | 18 | - | 15 | - | 20 | - | 20 | - | 20 | - | 20 | - | ns | |
| RAS Active Time | | tRAS | 42 | 100K | 42 | 100K | 45 | 100K | 45 | 100K | 48 | 100K | 50 | 100K | 50 | 100K | ns | |
| RAS Precharge Time | | tRP | 18 | - | 18 | - | 15 | - | 20 | - | 20 | - | 20 | - | 20 | - | ns | |
| RAS to RAS Bank Active Delay | | tRRD | 12 | - | 14 | - | 15 | - | 15 | - | 16 | - | 20 | - | 20 | - | ns | |
| CAS to CAS Delay | | tCCD | 1 | - | 1 | - | 1 | - | 1 | - | 1 | - | 1 | - | 1 | - | CLK | |
| Write Command to Data-In Delay | | tWTL | 0 | - | 0 | - | 0 | - | 0 | - | 0 | - | 0 | - | 0 | - | CLK | |
| Write Recovery Time | | tWR | 2 | - | 2 | - | 2 | - | 2 | - | 2 | - | 2 | - | 2 | - | CLK | |
| Data-In to Active Command | | tDAL | 5 | - | 5 | - | 5 | - | 5 | - | 5 | - | 5 | - | 5 | - | CLK | |
| DQM to Data-Out Hi-Z | | tDQZ | 2 | - | 2 | - | 2 | - | 2 | - | 2 | - | 2 | - | 2 | - | CLK | |
| DQM to Data-In Mask | | tDQM | 0 | - | 0 | - | 0 | - | 0 | - | 0 | - | 0 | - | 0 | - | CLK | |
| MRS to New Command | | tMRD | 2 | - | 2 | - | 2 | - | 2 | - | 2 | - | 2 | - | 2 | - | CLK | |
| Precharge to Data Output Hi-Z | CAS Latency = 3 | tPROZ3 | 3 | - | 3 | - | 3 | - | 3 | - | 3 | - | 3 | - | 3 | - | CLK | |
| | CAS Latency = 2 | tPROZ2 | 2 | - | 2 | - | 2 | - | 2 | - | 2 | - | 2 | - | 2 | - | CLK | |
| Power Down Exit Time | | tPDE | 1 | - | 1 | - | 1 | - | 1 | - | 1 | - | 1 | - | 1 | - | CLK | |
| Self Refresh Exit Time | | tSRE | 1 | - | 1 | - | 1 | - | 1 | - | 1 | - | 1 | - | 1 | - | CLK | 1 |
| Refresh Time | | tREF | - | 64 | - | 64 | - | 64 | - | 64 | - | 64 | - | 64 | - | 64 | ms | |

Note :

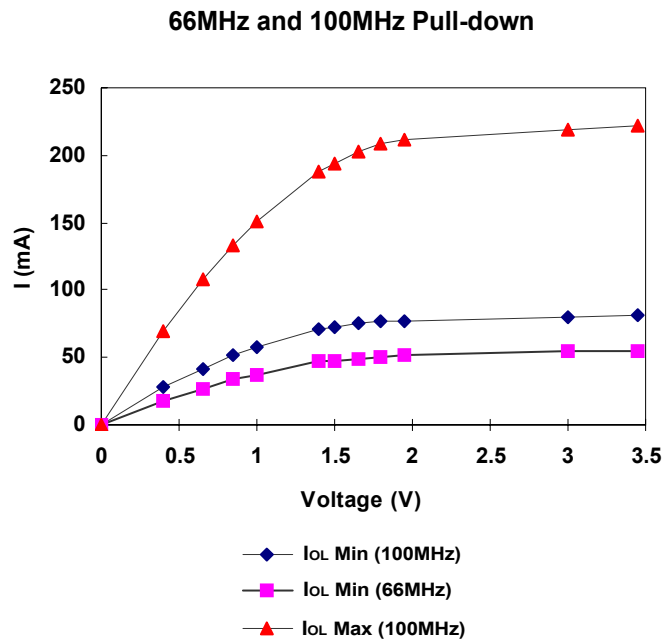
1. A new command can be given tRRC after self refresh exit

IBIS SPECIFICATION
IOH Characteristics (Pull-up)

| Voltage | 100MHz (Min) | 100MHz (Max) | 66MHz (Min) |
|---------|--------------|--------------|-------------|
| (V) | I(mA) | I(mA) | I(mA) |
| 3.45 | | -2.4 | |
| 3.3 | | -27.3 | |
| 3.0 | 0 | -74.1 | -0.7 |
| 2.6 | -21.1 | -129.2 | -7.5 |
| 2.4 | -34.1 | -153.3 | -13.3 |
| 2.0 | -58.7 | -197 | -27.5 |
| 1.8 | -67.3 | -226.2 | -35.5 |
| 1.65 | -73 | -248 | -41.1 |
| 1.5 | -77.9 | -269.7 | -47.9 |
| 1.4 | -80.8 | -284.3 | -52.4 |
| 1.0 | -88.6 | -344.5 | -72.5 |
| 0 | -93 | -502.4 | -93 |


IOI Characteristics (Pull-down)

| Voltage | 100MHz (Min) | 100MHz (Max) | 66MHz (Min) |
|---------|--------------|--------------|-------------|
| (V) | I(mA) | I(mA) | I(mA) |
| 0 | 0 | 0 | 0 |
| 0.4 | 27.5 | 70.2 | 17.7 |
| 0.65 | 41.8 | 107.5 | 26.9 |
| 0.85 | 51.6 | 133.8 | 33.3 |
| 1.0 | 58.0 | 151.2 | 37.6 |
| 1.4 | 70.7 | 187.7 | 46.6 |
| 1.5 | 72.9 | 194.4 | 48.0 |
| 1.65 | 75.4 | 202.5 | 49.5 |
| 1.8 | 77.0 | 208.6 | 50.7 |
| 1.95 | 77.6 | 212.0 | 51.5 |
| 3.0 | 80.3 | 219.6 | 54.2 |
| 3.45 | 81.4 | 222.6 | 54.9 |



DEVICE OPERATING OPTION TABLE
HY57V561620C(L)T(P)-6

| | CAS Latency | tRCD | tRAS | tRC | tRP | tAC | tOH |
|---------------|-------------|-------|-------|--------|-------|-------|-------|
| 166MHz(6ns) | 3CLKs | 3CLKs | 7CLKs | 10CLKs | 3CLKs | 5.4ns | 2.7ns |
| 143MHz(7ns) | 3CLKs | 3CLKs | 6CLKs | 9CLKs | 3CLKs | 5.4ns | 2.7ns |
| 133MHz(7.5ns) | 2CLKs | 3CLKs | 6CLKs | 9CLKs | 3CLKs | 5.4ns | 2.7ns |

HY57V561620C(L)T(P)-7

| | CAS Latency | tRCD | tRAS | tRC | tRP | tAC | tOH |
|---------------|-------------|-------|-------|-------|-------|-------|-------|
| 143MHz(7ns) | 3CLKs | 3CLKs | 6CLKs | 9CLKs | 3CLKs | 5.4ns | 2.7ns |
| 133MHz(7.5ns) | 2CLKs | 3CLKs | 6CLKs | 9CLKs | 3CLKs | 5.4ns | 2.7ns |
| 125MHz(8ns) | 3CLKs | 3CLKs | 6CLKs | 9CLKs | 3CLKs | 6ns | 3ns |

HY57V561620C(L)T(P)-K

| | CAS Latency | tRCD | tRAS | tRC | tRP | tAC | tOH |
|---------------|-------------|-------|-------|-------|-------|-------|-------|
| 133MHz(7.5ns) | 2CLKs | 2CLKs | 6CLKs | 8CLKs | 2CLKs | 5.4ns | 2.7ns |
| 125MHz(8ns) | 3CLKs | 3CLKs | 6CLKs | 9CLKs | 3CLKs | 6ns | 3ns |
| 100MHz(10ns) | 2CLKs | 2CLKs | 5CLKs | 7CLKs | 2CLKs | 6ns | 3ns |

HY57V561620C(L)T(P)-H

| | CAS Latency | tRCD | tRAS | tRC | tRP | tAC | tOH |
|---------------|-------------|-------|-------|-------|-------|-------|-------|
| 133MHz(7.5ns) | 3CLKs | 3CLKs | 6CLKs | 9CLKs | 3CLKs | 5.4ns | 2.7ns |
| 125MHz(8ns) | 3CLKs | 3CLKs | 6CLKs | 9CLKs | 3CLKs | 6ns | 3ns |
| 100MHz(10ns) | 2CLKs | 2CLKs | 5CLKs | 7CLKs | 2CLKs | 6ns | 3ns |

HY57V561620C(L)T(P)-8

| | CAS Latency | tRCD | tRAS | tRC | tRP | tAC | tOH |
|--------------|-------------|-------|-------|-------|-------|-----|-----|
| 125MHz(8ns) | 3CLKs | 3CLKs | 6CLKs | 9CLKs | 3CLKs | 6ns | 3ns |
| 100MHz(10ns) | 2CLKs | 2CLKs | 5CLKs | 7CLKs | 2CLKs | 6ns | 3ns |
| 83MHz(12ns) | 2CLKs | 2CLKs | 4CLKs | 6CLKs | 2CLKs | 6ns | 3ns |

HY57V561620C(L)T(P)-P

| | CAS Latency | tRCD | tRAS | tRC | tRP | tAC | tOH |
|--------------|-------------|-------|-------|-------|-------|-----|-----|
| 100MHz(10ns) | 2CLKs | 2CLKs | 5CLKs | 7CLKs | 2CLKs | 6ns | 3ns |
| 83MHz(12ns) | 2CLKs | 2CLKs | 5CLKs | 7CLKs | 2CLKs | 6ns | 3ns |
| 66MHz(15ns) | 2CLKs | 2CLKs | 4CLKs | 6CLKs | 2CLKs | 6ns | 3ns |

HY57V561620C(L)T(P)-S

| | CAS Latency | tRCD | tRAS | tRC | tRP | tAC | tOH |
|--------------|-------------|-------|-------|-------|-------|-----|-----|
| 100MHz(10ns) | 3CLKs | 2CLKs | 5CLKs | 7CLKs | 2CLKs | 6ns | 3ns |
| 83MHz(12ns) | 2CLKs | 2CLKs | 5CLKs | 7CLKs | 2CLKs | 6ns | 3ns |
| 66MHz(15ns) | 2CLKs | 2CLKs | 4CLKs | 6CLKs | 2CLKs | 6ns | 3ns |

COMMAND TRUTH TABLE

| Command | CKEn-1 | CKEn | \overline{CS} | \overline{RAS} | \overline{CAS} | \overline{WE} | DQM | ADDR | A10/ AP | BA | Note | |
|---------------------------|--------|------|-----------------|------------------|------------------|-----------------|-----|-------------------------------------|------------|----|------|--|
| Mode Register Set | H | X | L | L | L | L | X | OP code | | | | |
| No Operation | H | X | H | X | X | X | X | X | | | | |
| | | | L | H | H | H | | | | | | |
| Bank Active | H | X | L | L | H | H | X | RA | | V | | |
| Read | H | X | L | H | L | H | X | CA | L | V | | |
| Read with Autoprecharge | | | | | | | | | H | | | |
| Write | H | X | L | H | L | L | X | CA | L | V | | |
| Write with Autoprecharge | | | | | | | | | H | | | |
| Precharge All Banks | H | X | L | L | H | L | X | X | H | X | | |
| Precharge selected Bank | | | | | | | | | L | V | | |
| Burst Stop | H | X | L | H | H | L | X | X | | | | |
| DQM | H | X | | | | | V | X | | | | |
| Auto Refresh | H | H | L | L | L | H | X | X | | | | |
| Burst-Read-Single-WRITE | H | X | L | L | L | H | X | A9 Pin High (Other Pins OP code) | | | | |
| Self Refresh ¹ | Entry | H | L | L | L | L | H | X | X | | | |
| | Exit | L | H | H | X | X | X | X | | | | |
| L | | | | H | H | H | | | | | | |
| Precharge power down | Entry | H | L | H | X | X | X | X | X | | | |
| | | | | L | H | H | H | | | | | |
| | Exit | L | H | H | X | X | X | X | | | | |
| | | | | L | H | H | H | | | | | |
| Clock Suspend | Entry | H | L | H | X | X | X | X | X | | | |
| | | | | L | V | V | V | | | | | |
| | Exit | L | H | X | | | | X | | | | |

Note :

- Exiting Self Refresh occurs by asynchronously bringing CKE from low to high
- X = Don't care, H = Logic High, L = Logic Low. BA = Bank Address, RA = Row Address, CA = Column Address, Opcode = Operand Code, NOP = No Operation

PACKAGE INFORMATION

400mil 54pin Thin Small Outline Package

